

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)ATTY-DOCKET NO.
OGOH:089ASERIAL NO. 10/718,554
[Rule 1.53(b) Continuation of 09/913,644]APPLICANT
Tetsuya SATOU et al.FILING DATE
November 24, 2003GROUP
1774

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MEY	5,635,308	06/03/1997	Inoue et al.	428	690	—
MEY	4,720,432	1/1988	VanSlyke et al.	428	457	—
MEY	5,792,557	8/1998	Nakaya et al.	428	411.1	—

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO	YES
MEY	06-240245	08/30/1994	Japan (English abstract)	—	—	x	
MEY	07-157754	06/20/1995	Japan (English abstract)	—	—	x	
MEY	07-216352	08/15/1995	Japan (English abstract)	—	—	x	
MEY	08-302341	11/19/1996	Japan (English abstract)	—	—	x	
MEY	07-249490	09/26/1995	Japan (English abstract)	—	—	x	
MEY	08-311442	11/26/1996	Japan (English abstract)	—	—	x	
MEY	08-012969	01/16/1996	Japan (English abstract)	—	—	x	
MEY	08-333569	12/17/1996	Japan (English abstract)	—	—	x	
MEY	11-255716	09/21/1999	Japan (English abstract)	—	—	x	
MEY	10-245549	09/14/1998	Japan (English abstract)	—	—	x	
MEY	09-268284	09/14/1998	Japan (English abstract)	—	—	x	
MEY	11-74079	03/16/1999	Japan	—	—		x

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER	DATE CONSIDERED

Marie L. Yarnitzky

Jan. 30, 2004

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.